Hellenic Complex Systems Laboratory

Quality: A Software Tool for Statistical Quality Control Design

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Quality: A Software Tool for Statistical Quality Control Design

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Search Terms: quality control, quality control design, measurement, total allowable analytical error, fraction nonconforming, critical systematic error, critical random error, decision limits, probability for rejection, probability for false rejection

Introduction

Alternative quality control (QC) rules and procedures can be applied to a process to statistically test the null hypothesis, that the process conforms to the quality specifications and consequently is in control, against the alternative, that the process is out of control. A statistical type I error is committed when a true null hypothesis is rejected. We then have a false rejection of the run of the process. The probability of a type I error is called the probability for false rejection. A statistical type II error is committed when a false null hypothesis is accepted. We fail then to detect a significant change in the probability density function of a quality characteristic of the process. The probability of rejection of a false null hypothesis equals the probability of detection of the nonconformity of the process to the quality specifications.

The program Quality was developed to design and explore single-value QC rules to meet defined quality specifications.

The program

The program provides two modules:

Design

This module estimates various parameters of a measurement process, designs the single-value quality $S(x; m, s, l_i)$ (see Notation) control rule to be applied. Then, it plots the probability density function (pdf) and the cumulative distribution function (cdf) of the control measurements, as well as the probability for rejection for the random error and systematic error of the QC rule (see Figures 1 and 2).

Compare

This module explores and compares pairs of alternative single-value statistical QC rules $S(x; m, s, l_i)$ (see Notation) applied on tuples x of n_i control measurements, k_i of them distributed as $\mathcal{N}(m, s^2)$, and n_i -k_i as $\mathcal{N}(0,1)$, plotting the probabilities for rejection $P(n_i, k_i, m, s; 0,1, l_i)$ of the two statistical QC rules, their difference, relative difference, and ratio (see Figures 3 and 4).
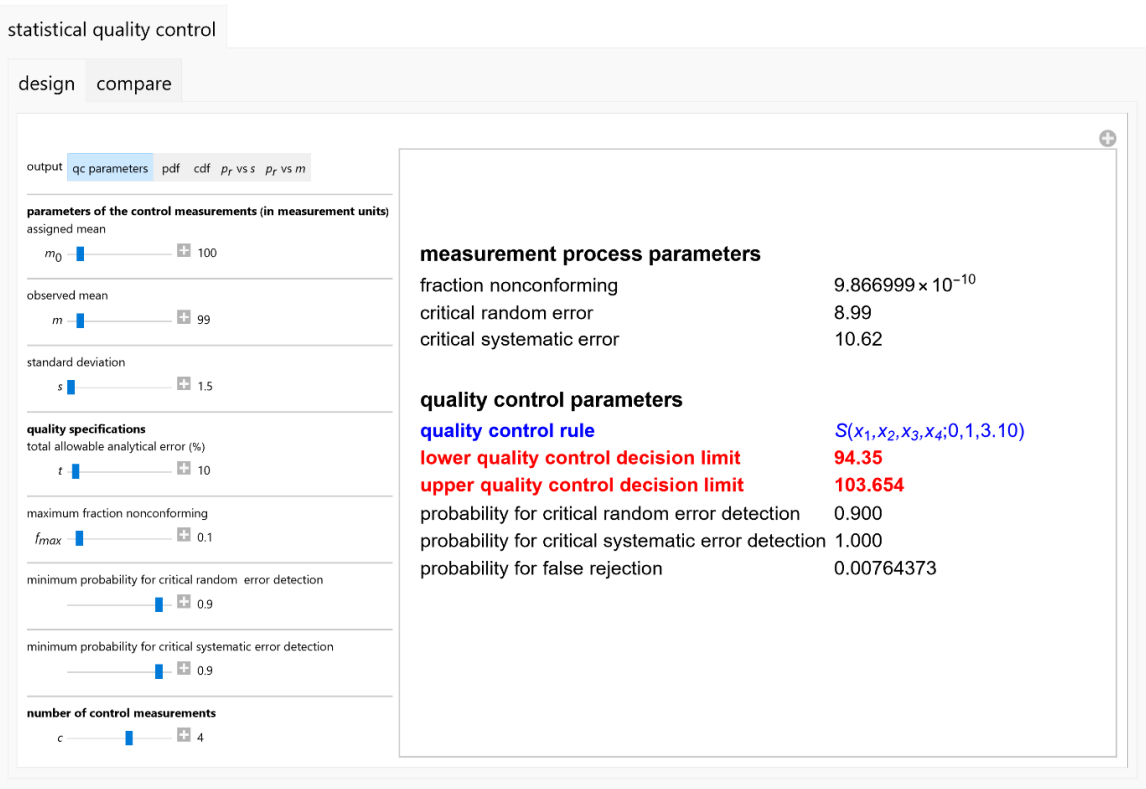
Figure 1: The measurement process parameters and the QC parameters of a measurement process, with the settings at the left.
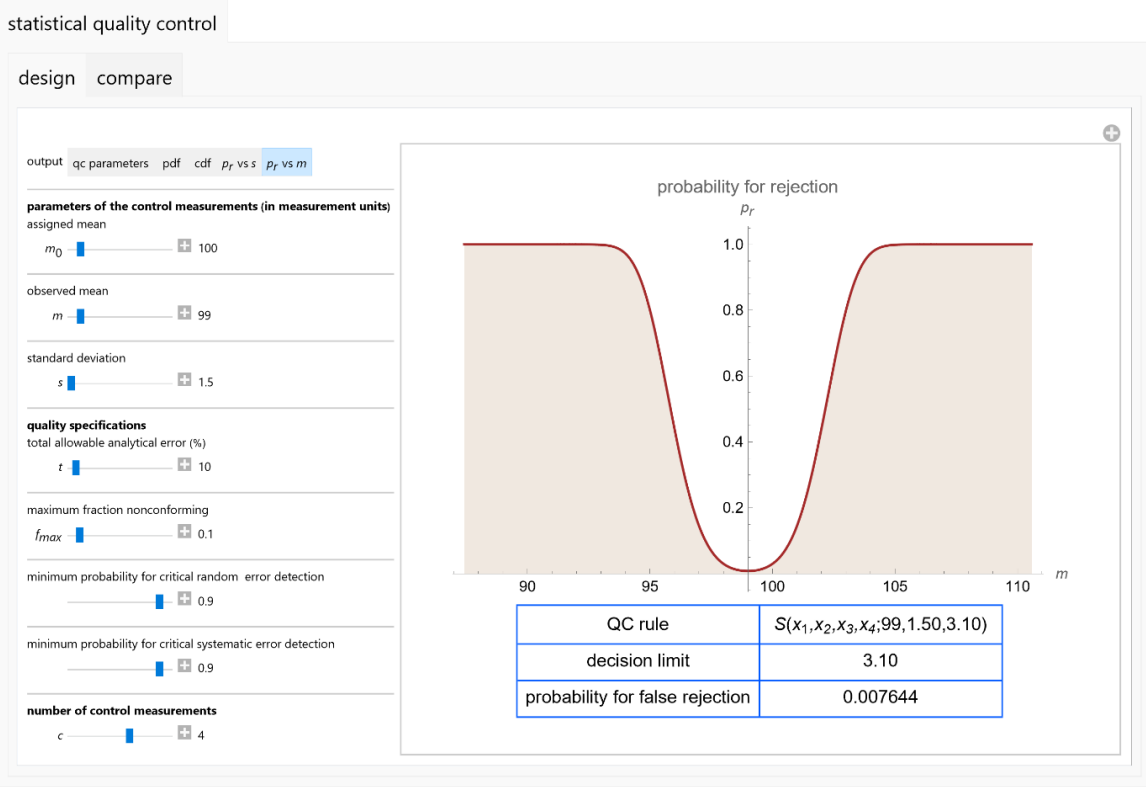

Figure 2: The probability for rejection of a QC rule vs the mean m of the control measurements, with the settings at the left.
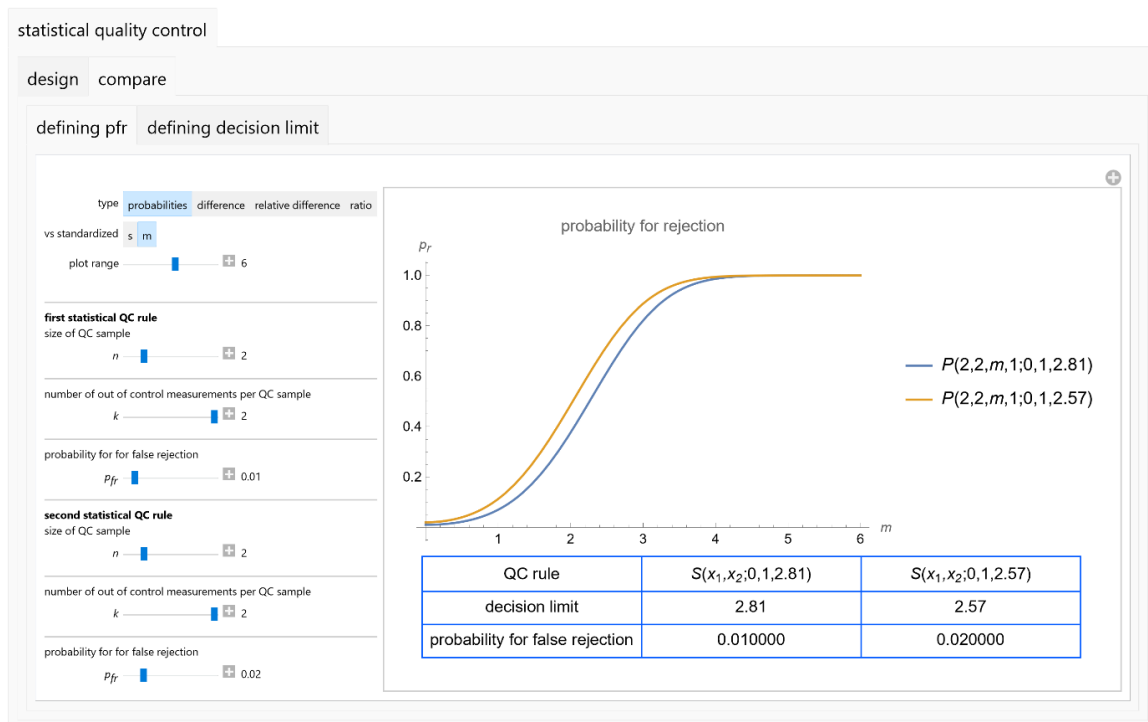
Figure 3: The probabilities for rejection of two alternative QC rules vs the standardized observed mean m of the control measurements, with the settings at the left.
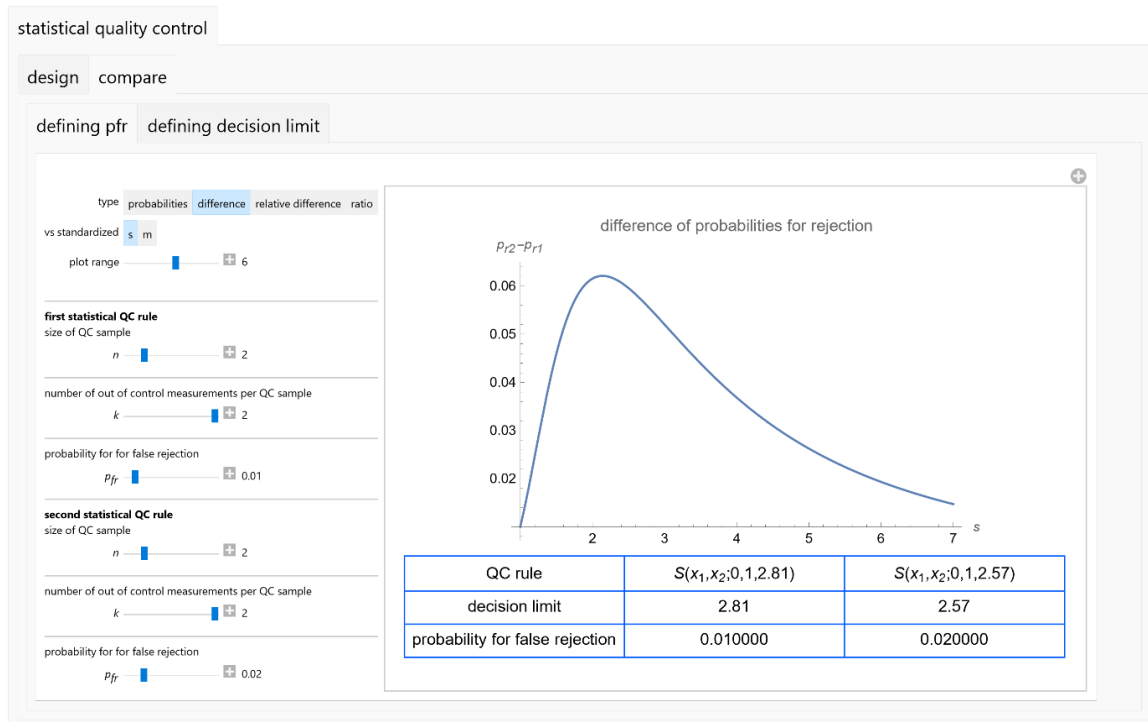

Figure 4: The difference probabilities for rejection of two alternative QC rules vs the standardized standard deviation s of the control measurements, with the settings at the left.

Details

Let m_0, m, and s be the assigned mean, the observed mean, and the standard deviation of the control measurements. Let t be the total allowable analytical error (expressed as a percentage of the assigned

mean), and f_{max} the maximum acceptable fraction nonconforming. Then, the following equations are used to estimate the respective parameters [1, 2, 3]:

(a) The fraction nonconforming f:

$$f = 1 - \int_{m_0\left(1-\frac{t}{100}\right)}^{m_0\left(1+\frac{t}{100}\right)} \left(\frac{e^{-\frac{(-m+z)^2}{2s^2}}}{s\sqrt{2\pi}}\right) dz$$

(b) the critical random error s_c:

$$1 - \int_{m_0\left(1-\frac{t}{100}\right)}^{m_0\left(1+\frac{t}{100}\right)} \left(\frac{e^{-\frac{(-m+z)^2}{2s_c^2}}}{s_c\sqrt{2\pi}}\right) dz = f_{max}$$

(c) the critical systematic error m_c:

$$\int_{m_0\left(1-\frac{t}{100}\right)}^{m_0\left(1+\frac{t}{100}\right)} \left(\frac{e^{-\frac{(\epsilon\, m_c-m+z)^2}{2s^2}}}{s\sqrt{2\pi}}\right) dz = f_{max}$$

where f_{max} the maximum acceptable fraction nonconforming, and $\epsilon = 1$ if $m_o < m$ and $\epsilon = -1$ otherwise,

(d) the factor l of the decision limits $m \pm l\,s$ of the QC rule $S(x; m, s, l)$ is the minimum solution of both of the following two equations for the variable l, where p_{s_c} and p_{m_c} the minimum probabilities for critical random and systematic error detection:

$$\left(\int_{m-l\,s}^{m+l\,s} \left(\frac{e^{-\frac{(-m+z)^2}{2s_c^2}}}{s_c\sqrt{2\pi}}\right) dz\right)^n = p_{s_c}$$

$$\left(\int_{m-l\,s}^{m+l\,s} \left(\frac{e^{-\frac{(\epsilon\, m_c-m+z)^2}{2s^2}}}{s\sqrt{2\pi}}\right) dz\right)^n = p_{m_c}$$

with ϵ as before in (c),

(e) the probability for false rejection of the QC rule $S(x; m, s, l)$:

$$P(n, n, m, s; m, s, l) = 1 - \left(\int_{m-l\,s}^{m+l\,s} \left(\frac{e^{-\frac{(-m+z)^2}{2s^2}}}{s\sqrt{2\pi}}\right) dz\right)^n$$

(f) the probability for rejection for the random error s_e and the systematic error m_e of the QC rule $S(x; m, s, l)$:

$$P(n, n, m_e, s_e, m, s, l) = 1 - \left(\int_{m-l\,s}^{m+l\,s} \left(\frac{e^{-\frac{(m_e-m+z)^2}{2s_e^2}}}{s_e\sqrt{2\pi}}\right) dz\right)^n$$

$$P(n, k, m_e, s_e; m, s, l) = P(k, k, m_e, s_e; m, s, l) + P(n-k, n-k, m, s; m, s, l) -$$

$$P(k, k, m_e, s_e; m, s, l) P(n-k, n-k, m, s; m, s, l)$$

Conclusion

The program Quality can be used as an educational or laboratory tool to design and evaluate alternative single-value QC rules for a measurement process.

References

[1] A. T. Hatjimihail, A Tool for the Design and Evaluation of Alternative Quality Control Procedures, Clinical Chemistry 38, 1992 pp. 204–210.

[2] A.T. Hatjimihail. Tool for Quality Control Design and Evaluation, Wolfram Demonstrations Project, Champaign: Wolfram Research, Inc., 2010.

[3] A. T. Hatjimihail, Estimation of the Optimal Statistical Quality Control Sampling Time Intervals Using a Residual Risk Measure, PLoS ONE 4(6), 2009 p. e5770.

Abbreviations

QC: quality control
pfr: probability for false rejection
pdf: probability density function
cdf: cumulative distribution function

Notation

$\boldsymbol{x}$: n-tuple $(x_1, x_2, \ldots, x_n)$ of control measurements
m_0 : the assigned mean of the control measurements
m : the observed mean of the control measurements
s : the observed standard deviation of the control measurements
m_e : the observed mean of the control measurements when the measurement process is out of control
s_e : the observed standard deviation of the control measurements when the measurement process is out of control
s_c : the critical random error
m_c : the critical systematic error
p_r : probability for rejection
p_{fr} : probability for false rejection
p_{s_c} : the probability for critical random error detection
p_{m_c} : the probability for critical systematic error detection
$S(\boldsymbol{x}; m, s, l)$: statistical QC rule with decision limits $m \pm ls$, applied on $\boldsymbol{x}$. The rule rejects an analytical run if: $\exists\, x_i \in \boldsymbol{x} : x_i < m - ls \lor x_i > m + ls$
$\mathcal{N}(m, s^2)$: normal distribution with mean m and standard deviation s.
$P_S(n, k, m_e, s_e; m, s, l)$: probability for rejection of the QC rule $S(\boldsymbol{x}; m, s, l)$ applied on a n -tuple $\boldsymbol{x}$ of control measurements, k of them distributed as $\mathcal{N}(m_e, s_e^2)$ and n-k as $\mathcal{N}(m, s^2)$

The program interface

1. Design

   1.1. Input.

      1.1.1. Parameters of the control measurements (in arbitrary measurement units)

         1.1.1.1. The assigned mean m_0 ($0.01 \le m_0 \le 1000.0$),

         1.1.1.2. The observed mean m when the process is in control ($0.01 \le m \le 1000.0$), and

         1.1.1.3. The standard deviation s when the process is in control ($0.01 \le s \le 1000.0$).

      1.1.2. Quality specifications of the measurement process

         1.1.2.1. The total allowable error t (as a percentage of the assigned mean) ($0.01 \le t \le 200.0$),

         1.1.2.2. The maximum acceptable fraction f_{max} of measurements nonconforming to the specifications ($0.01 \le f_{max} \le 1.0$),

         1.1.2.3. The minimum acceptable probability p_{s_c} for detection of the critical random error ($0.01 \le p_{s_c} \le 0.99$).

         1.1.2.4. The minimum acceptable probability p_{m_c} for detection of the critical systematic error ($0.01 \le p_{m_c} \le 0.99$).

         1.1.2.5. The number n of control measurements ($1 \le n \le 6$).

   1.2. Output

      1.2.1. Table of QC parameters

         1.2.1.1. The fraction nonconforming f,

         1.2.1.2. The critical random error s_c ,

         1.2.1.3. The critical systematic error m_c ,

         1.2.1.4. The QC decision limits $m \pm l\,s$,

         1.2.1.5. The probability p_{s_c} for critical random error detection,

         1.2.1.6. The probability p_{m_c} for critical systematic error detection

         1.2.1.7. The probability p_{fr} for false rejection

      1.2.2. Plots

         1.2.2.1. The probability density function (pdf) plot of the control measurements,

         1.2.2.2. The cumulative distribution function (cdf) plot of the control measurements,

         1.2.2.3. the probability for rejection plot for the random error (p_r vs s), and

         1.2.2.4. the probability for rejection plot for the systematic error (p_r vs m).

The parameters are estimated and the functions are plotted if $10^{-100} \le f \le f_{max}$

2. Compare

   2.1. Input.

      2.1.1. Plot options

         2.1.1.1. Type of error:

            2.1.1.1.1. Random error

            2.1.1.1.2. Systematic error

Source Code

Programming language: Wolfram Language

Availability: The updated source code is available at:

https://www.hcsl.com/Tools/Quality/Quality.nb

Software Requirements

Operating systems: Microsoft Windows, Linux, Apple iOS

Other software requirements: Wolfram Player®, freely available at: https://www.wolfram.com/player/
or Wolfram Mathematica®.

System Requirements

Processor: Intel Core i7® or equivalent CPU

System memory (RAM): 16GB+ recommended.

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